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Evaluating Security Claims of the Cigent Secure SSD

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1 PURPOSE

The Cigent Secure SSD allows for operation in what is called 'dual mode'. This feature permits the user to configure and access their drive as two separate storage systems. This document will refer to the 'regular' storage volume as 'Side A' of the drive. The secure storage system will be referred to as 'Side B'. According to Cigent documentation neither of these storage systems is aware that the other exists and the host Operating System is only able to access one at a time.

CPR Tools was tasked to determine if data could be recovered from the 'hidden' storage system of the drive using commercially available and proprietary data recovery tools.

2 DRIVE UNDER TEST

- Manufacturer
 - Cigent Secure SSD[™]
- Model
 - K2 (testing Dual Mode[™])
- Size
 - o 1TB (960GB)
- Interface
 - PCIe (NVMe)
- Serial Number
 - o AF710716104D0000156
- Firmware
 - o ECFM13TO

3 TEST PREPARATION

The Operating System used for setup was Windows 10. Using the software tools provided commercially by Cigent the SSD was setup following the on-screen instructions. The drive was divided into two equal parts of 480GB and formatted. Once formatted 100 test text (.txt) files were added to Side B and Side B was closed. Upon reboot Side A was available through the Operating System and Side B was not detected using Explorer or Disk Management.

NOTE: CPR Tools lab personnel were not given any utilities to 'see' the secure area.



4 TEST PLAN

CPR Tools performed the following steps during testing of the device:

- Physical Examination of Subject and Exemplar drives
- Review SMART data
- Examine physical drive access with a hex editor
- Examine output of the SED Util utility
- Directly examine the FLASH Storage hardware

Each of these steps is detailed below.

5 PHYSICAL REVIEW OF SUBJECT AND EXEMPLAR DRIVES

As the capacity of the subject drive was unknown to the examiner upon presentation, a physical comparison to exemplar drives of varying capacities was made.



Figure 1 - Storage Chips Of Subject Drive



Figure 2 - Storage Chips From Exemplar 960GB Drive



Figure 3 - Storage Chips from Exemplar 480GB Drive

The examiner made note that the storage chip identifier from the exemplar 480GB drive did not match those of the target drive's storage chips, but the storage chips from the exemplar 960GB drive did match.

6 TEST – REVIEW OUTPUT OF S.M.A.R.T UTILITY

The CrystalDiskInfo utility identified the target drive as having a capacity of 480.0 GB. The same utility identified an exemplar 480GB drive as having a capacity of 480.1 GB. This 0.1GB difference is significant from a forensics standpoint, as any difference from an exemplar sample indicates a path worthy of further investigation. (See Figure 4 and Figure 5)



This seemingly minor discrepancy was an indication that while the subject drive was interpreted as 480GB capacity by the software, there was likely some kind of modification to the addressable capacity of the drive.

The utility also displays basic information derived from how the operating system, Windows 10, identifies the drive. This information includes normal S.M.A.R.T. values as well as drive capacity, the NVMe version, Firmware and Serial Number.



Figure 4 - Output of S.M.A.R.T. Utility Scan on Target Drive

Figure 5 - Output of S.M.A.R.T. Utility Scan on Exemplar Drive



7 EXAMINATION WITH HEX EDITOR

Using an industry standard Hex Editor, we found the drive to be accessible as a physical device. Scan of the device reported no errors but upon further examination, the only visible data was test data from Side A, no test data from Side B was viewable. Side A, as shown in the hex editor is depicted in Figure 6.

Hard disk 0																					
Partitioning style: GPT																					
Name			_		Fx	t [Si	ze (reate	d		M	lodif	ied		A	ccessed Attr			ectbr	•
Start sectors		-	-	-		1	70	KR			-		2 411		-					0	
Dartition 1 /		1	601	AD												24					
Partition 2 (NIT	- '	447												22	760					
Partition 2 (t	E.)				INI	4	17	JD AD											52,	100	
Unpartitione	ea sp	ace					1.7 1	NB											937,0		
Offset 000000000 000000010	0 33 06	1 C0 B9	2 8E 00	3 D0 02	4 BC FC	5 00 F3	6 7C A4	7 8E 50	8 C0 68	9 8E 1C	A D8 06	B BE CB	C OO FB	D 7C B9	E BF 04	F 00 00		.∎ؾ Ëû	¿ 1	^	
0000000020	BD	ΒE	07	80	7E	00	00	7C	OB	OF	85	0E	01	83	C5	10	1/234 ~	1	Â		
0000000030	E2	F 1	CD	18	88	56	00	55	C6	46	11	05	C6	46	10	00	âñÍ ∎V UA	EF Æl	F		
0000000040	Β4	41	BB	AA	55	CD	13	5D	72	OF	81	FB	55	AA	75	09	´A≫ªUÍ]r	ûU	ªu		
0000000050	F 7	C1	01	00	74	03	FE	46	10	66	60	80	7E	10	00	74	÷Á t þF	f` I ∼	t		
0000000060	26	66	68	00	00	00	00	66	FF	76	08	68	00	00	68	00	&fh fÿ	rv h	h		
0000000070	7C	68	01	00	68	10	00	Β4	42	8A	56	00	8B	F 4	CD	13	h h ´E	IV I	ôÍ		
0000000080	9F	83	C4	10	9E	EB	14	B8	01	02	BB	00	7C	8A	56	00	IIÀ lë ,	»	V		
0000000090	8A	76	01	8A	4E	02	8A	6E	03	CD	13	66	61	73	1C	FE	IV IN In	Í fas	∋þ		
0400000000	4E	11	75	OC	80	7E	00	80	OF	84	8A	00	Β2	80	EΒ	84	Nu I~∣	2	ë		
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000000000000000000000000000000000000000	AA	75	6E	FF	76	00	E8	8D	00	75	17	FA	BO	D1	E6	64	ªunÿv è	u ú°Í	Næd		
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UUUUUUU0000E0	00	FB	B8	00	BB	CD	1A	66	23	CO	75	ЗB	66	81	FB	54	û, ≫I f#	Au;f	ûΤ		
00000000FO	43	50	41	75	32	81	F9	02	01	72	20	66	68	07	BB	00	CPAu2 ú	r,fh	×		
0000000110	00	60	68	00	02	00	00	66 00	68	08	00	00	00	66	53	60	th th	съ і	151 C		
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0000000120	19	20	00 B7	00	07 FP	UD DP	7U V	DA BA	32 07	L D L D	EA 02	20	PC BS	00	32	EN EN	an 172	ioe iiiiiiiiiiiiiiiiiiiiiiiiiiiiiiiiiiii	25		
000000130	10	nn nn	07	88	ED	20	30	00	74	no no	BB	07	00	07 B4	32 0 म	C.4	. e 1 ă⊣∕ +	ε μ »	∠a ∕ f		
000000140	10	EB	F2	F4	EB	FD	2B	Ca	F4	64	EB	00	24	02	EO	FR	80.0 U	dë ¢	àn		
000000150	24	02	03	49	6F	76	61	6C	69	64	20	70	61	72	74	69	S ÃInvali	d par	rti		
0000000100	74	69	6F	6F	20	74	61	62	60	65	00	45	72	72	6F	72	tion tabl	e Er	ror		
0000000180	20	6C	6F	61	64	69	6E	67	20	6F	70	65	72	61	74	69	loading	oper	ati		
0000000190	6E	67	20	73	79	73	74	65	6D	00	4D	69	73	73	69	6E	ng svstem	Miss	∋in		
00000001A0	67	20	6F	70	65	72	61	74	69	6E	67	20	73	79	73	74	g operati	ng s	vst		
00000001B0	65	6D	00	00	00	63	7B	9A	00	00	00	00	00	00	00	00	em c{	- · ·	2		
00000001C0	02	00	EE	FE	FF	FF	01	00	00	00	FF	FF	FF	FF	00	00	îþÿÿ	ÿÿÿÿ	ý		
00000001D0	00	00	00	00	00	00	00	00	00	00	00	00	00	00	00	00					
00000001E0	00	00	00	00	00	00	00	00	00	00	00	00	00	00	00	00					
00000001F0	00	00	00	00	00	00	00	00	00	00	00	00	00	00	55	AA			Ū₫		
0000000200	45	46	49	20	50	41	52	54	00	00	01	00	5C	00	00	00	EFI PART	1		~	
Sector 0 of 92	7602	504								(Offer	ot.							0		
Sector 0 of 95/092304 Offset: 0																					

Figure 6 - Hex Editor display of Side A



8 EXAMINATION WITH SED UTIL

SED Util is a utility created by the Drive Trust Alliance and is a full featured command line interface for managing all aspects of drives which conform to the OPAL specification. The SED Util reports the locked or unlocked status for drives supported under the OPAL specifications seen in the Locking function (0x0002). Upon examination with SED Util, the software reported locked ranges and indicated that the drive conformed to the OPAL specification(s) for locked ranges.

Figure 7 depicts the output of the SED Util's review of the drive.

```
/dev/nvme1 NVMe PCIe SSD
                                                         ECEM13TO
AF710716104D00000156
TPer function (0x0001)
    ACKNAK = N, ASYNC = N. BufferManagement = N, comIDManagement = Y, Streaming
= Y, SYNC = Y
Locking function (0x0002)
    Locked = N, LockingEnabled = Y, LockingSupported = Y, MBRDone = N, MBREnabled
= N, MediaEncrypt = Y
Geometry function (0x0003)
    Align = Y, Alignment Granularity = 8 (4096), Logical Block size = 512, Lowest
Aligned LBA = 0
SingleUser function (0x0201)
    ALL = N, ANY = N, Policy = Y, Locking Objects = 9
DataStore function (0x0202)
   Max Tables = 9, Max Size Tables = 10485760, Table size alignment = 1
OPAL 2.0 function (0x0203)
   Base comID = 0x07fe, Initial PIN = 0x0 , Reverted PIN = 0x0 , comIDs = 1
    Locking Admins = 4, Locking Users = 9, Range Crossing = N
TPer Properties:
 MaxComPacketSize = 16384 MaxResponseComPacketSize = 16384
 MaxPacketSize = 16364 MaxIndTokenSize = 16328 MaxPackets = 1
 MaxSubpackets = 1 MaxMethods = 1 MaxSessions = 1
 MaxAuthentications = 9 MaxTransactionLimit = 1 DefSessionTimeout = 0
Host Properties:
 MaxComPacketSize = 2048 MaxResponseComPacketSize = 2048
```

Figure 7 - Output of the SED Util's view of the target drive

It should be noted that the settings for *LockingEnabled* and *MediaEncrypt* show 'on' which provided an indication that one or more hidden partitions might exist on the target drive beyond the reported LBA range.



9 **RECOVERY ATTEMPTS**

Using industry standard and proprietary hardware and software utilities, several additional attempts to access user data were made, including attempts to read from sectors outside the reported LBA range (Side 2). These attempts were not successful.

Based on these experiences, we initiated more advanced recovery methodologies which directly target the hardware itself.

10 POST CHIP-OFF X-RAY OF STORAGE MEDIA

The FLASH chips were removed from the NVMe PCB. As part of our standard operating procedure when performing chip-off recoveries, we employ an X-RAY machine to review and ensure that no damage was done during the chip removal process. Figure 8 depicts the post chip-off X-RAY of the chip removed from the subject drive.



Figure 8 - X-RAY of Storage Chip Removed From Subject Drive

Examination of the X-RAY image revealed no damage to the bond wires or traces, indicating that the chip-off procedure was successful.



11 DIRECT EXAMINATION OF FLASH STORAGE

Once removed from the NVMe PCB the chips were examined directly using a BGA Chip Reader.



Figure 9 - BGA FLASH Chip

All data recovered from the chips were saved to binary 'dumps'. The binary 'dumps' were then scanned for data. The scan did not reveal any recognizable data, nor did it reveal any ECC patterns. A sample of the output from these scans is depicted in Figure 10 and reveals nothing more than random data.

💹 Phy image 0 🗙 🔯 Workspace																	
	00	01	02	03	04	05	06	07	08	09	0A	0B	00	0D	0E	0 F	
0076492200	C7	89	6E	37	66	4 F	A8	04	45	04	DF	FB	27	9B	2E	B9	C%n7f0".E.Bû'>.*
0076492210	18	59	AE	0B	1B	74	B5	2E	C9	CF	34	45	4C	D8	51	BE	Y®.tµ ÉÏ4ELØQ%
0076492220	08	6B	CE	E7	59	C 8	58	64	2C	FE	9E	B2	B9	72	31	E1	.kÎçYÈXd,þž°'r1á
0076492230	26	F8	39	67	15	2E	BE	3C	EB	01	DD	31	10	15	Ε9	9C	&ø9g%<ë.Ý1éœ
0076492240	48	44	36	0C	4B	7D	64	1A	F6	19	68	2D	7C	11	FF	3B	HD6.K}d.ö.h- .ÿ;
0076492250	46	26	16	9D	63	0C	3C	66	6E	FO	ΑE	34	8D	FF	D5	BE	F₄.□c. <fnð©4□ÿõ¾< th=""></fnð©4□ÿõ¾<>
0076492260	5A	Β7	DC	EC	8B	Ε4	E4	76	B1	97	BY	D7	27	68	69	50	Z·Üì<ääv±=°×'hiP
0076492270	3E	75	9E	71	A6	F7	D1	40	97	40	93	86	C6	76	42	81	>užg¦÷Ň@−@``†ÆvB□
0076492280	42	2A	5D	DD	E9	B2	C2	C8	A1	00	79	E2	5D	53	F6	41	B*]Yé*AÉ;.yâ]SöA
0076492290	38	60	93	18	cç	68	11	27	A2	EE	2D	63	cc	3E	A3	1B	8`".Ih.'¢î-cI>£.
00764922A0	43	63	ED	B9	0A	B5	3C	B1	BC	C0	C4	7 F	0A	Β4	B2	60	Cci'.µ<±*AA
00764922B0	55	20	4E	70	0E	42	Α7	DA	E2	F5	A3	BD	74	1E	C7	4F	U Np,B§Uãõ£*t.ÇO
00764922C0	C4	7 F	91	07	C2	55	B3	1E	C6	A1	EE	98	8E	4C	A5	7A	A AU'.E'I~ZL#z
00764922D0	FB	6F	16	FA	87	9A	1F	OF	DF	7A	38	16	BE	AA	C5	98	uo.u‡sBz;.%*A*
00764922E0	D7	B1	40	33	42	C7	DB	45	EO	BE	03	E6	9B	33	33	05	×±@3BCUEá≈.æ>33.
00764922F0	88	7E	30	F5	CD	84	FO	56	85	DF	71	9A	16	70	02	85	~001'8VBqs. .µ
0076492300	EA	OD	68	6D	6A	3D	4D	6F	10	FC	OF	5D	8E	47	53	F4	e.hmj=Mo.u.]ZGSo
0076492310	6C	CO	FO	E3	93	07	29	A2	17	#5	74	DE	61	FO	4D	33	IAda"C)¢.≆tpadm3
0076492320	19	71	21	35	1F	25	58	50	81	09	E7	15	D2	81	10	5E	. /5.%X]±.ç.0±.^
0076492330	67	68	30	5E	13	32	47	05	22	88	9A	95	84	82	E9	58	Cn0^.2G.",s•",ex
0076492340	29	11	39	60	5E	36	00	E.4	55	E4	15	00	21	13	80	6/	e.yr.orala.ra.ug
0076492350	H b	Dr	41	34	20	DU	82	34	Er	D2	80	3E	12	C4	55	50	BN:-D-410C>~RUP
0076492360	Co.	99	/5	11	09	01	20	30	10	90	91	En.	11	10	43	00	E ul.a 6}Die.øch
0076492370	57	CE.	UZ EC	40	57	D8	BH	50	24	57	5/	60	22	95	UB	45	Minute Division 1
0076492380	25	40	10	50	0D	10	01	10	-0	10	00	11	D1	03	50	20	AII MOAP Uμ.±CP*
0076492390	60	10	A1	JD FO	14	01	r4 DA	16	20	19 51	04 FC	41	00	30	c /	2/ FA	.0.[0.0.sAP +
0076492380	65	01	50	56	17	FA	OF	20	10	00	20	6B	FO	34	DC	BF	ovpV ar D stadt
0076492300	45	25	F1	20	94	20	8D	20	QF	R S	0.9	B S	CF	02	62	78	F&áŤ″ÉDĚŽå uŤ h(
0076492300	CC	ĉĂ	AR	20	OF	96	18	81	10	75	FO	45	40	02	3.8	FA	ŤÊκ)ž= Ο èNG ⁸ 86
00764923E0	38	Ac	01	53	88	FD	58	0.0	28	F6	AA	53	FF	20	46	De	2 S^#[~+##SbFF0
00764923E0	AF	1.5	83	D3	6B	De	E6	EC	DD	CF	C7	10	BI	6F	70	OF	- ióköæiýfc.+nl
0076492400	78	12	24	FB	28	70	Ā4	99	83	68	44	50	65	82	EF	93	x.sû(\w ^m fbD\e.ï"
0076492410	E9	18	1 F	20	95	39	39	CF	34	C8	A7	5A	88	70	C1	B2	éŸ99Ť4ÈSZ^1Å*
0076492420	77	1F	6F	81	22	10	70	10	29	31	C7	34	C9	DE	70	EB	w.n0".}.)1C4ÉÞ}ë
0076492430	F9	30	41	4C	E1	FE	1B	50	5F	76	co	25	D6	9A	E9	19	ù0ALáb.P vÁ%Öšé.
Address: Selec	ted:																

Figure 10 – Random Page Data pulled from Chip Dump



Figure 11 and Figure 12 depict "page bit" views of chip data. All white locations represent a value of zero; the locations in black represent a value of one.

Figure 11 was taken from the target drive. Given that there are no discernable patterns, we are confident that there is no viable data in this view. However, data may be present and encrypted.

Figure 12 was taken from an exemplar drive. Even a cursory examination displays identifiable patterns which represent, from left to right, user data, Translator, ECC Data and more user data.



Figure 11 - A page bit view of the chip data displaying no discernable patterns



Figure 12 - A page bit view of chip data from the exemplar drive displaying user data.

12 SUMMARY OF FINDINGS

In evaluating the security measures on the Cigent Secure SSD, our engineers employed a number of techniques to obtain user data from the "hidden side" once the drive was in its "dual mode" state. Note: The target drive was presented without a drive information label.

The target drive reported a capacity of 480GB; the exemplar, known to be a 480GB drive, reported 480.1GB. This small discrepancy led to a more thorough physical comparison between the two. It was noted that the exemplar drive had fewer storage chips on the PCB than the target drive.

Employing an industry standard hex editor, we examined the target drive as a physical device. The device was able to be opened. A total of 937,692,504 (480GB) sectors were able to be displayed.

Next, we examined the target drive using the SED Util software. The software reported a value of 'on' for *LockingEnabled* and *MediaEncrypt*. This information, combined with the physical differences between the target and the exemplar drive, were indicators that one or more hidden partitions might exist on the drive beyond the drive's reported LBA range. As all traditional methods had been exhausted, we moved on to advanced methods by performing a chip-off recovery.

The FLASH storage chips were removed and examined under X-RAY to ensure that no damage was incurred during the chip removal process.



The FLASH storage chips were then accessed using a BGA chip reader. Scans of the chip did not reveal any recognizable data, nor did it reveal any ECC patterns. Next, page bit views of the data were rendered and examined. All data appeared to be random which led us to believe it was encrypted and we were unable to recover any user data from the chips.

13 CONCLUSION

After a thorough review utilizing both basic and advanced recovery and forensic techniques, no user data was able to be recovered from Side B of the Cigent Secure SSD.